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RESPONSE UNDER 37 CFR 1.116 EXPEDITED PROCEDURE EXAMINING GROUP 2876

> PATENT APPLICATION · · rateroch
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> 8/8/03 Docket No.: 9903-041 Client Ref. No.: S01US012

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of: Sung-Muk LIM, et al.

Serial No.:

10/027,639

Examiner:

Trail, Allyson N.

Filed:

December 19, 2001

Group Art Unit:

2876

Confirmation No.:

1485

For:

METHOD AND APPARATUS FOR DETECTING DEFECTIVE

MARKINGS ON A SEMICONDUCTOR PRODUCT

Mail Stop AF Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

AMENDMENT AFTER FINAL REJECTION UNDER 37 CFR 1.116

Responsive to the Final Office Action, Paper No. 05-2005, dated May 6, 2005, please amend the application as follows.

Amendments to the Claims are reflected in the listing of claims, which begins on page 2 of this paper.

Remarks/Arguments begin on page 8 of this paper.

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Application No. 10/027,639